

Search Notes**Application/Control No.**

10/663,207

Examiner

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Applicant(s)/Patent under Reexamination

CHAN, ALBERT

Art Unit

1733

SEARCHED

Class	Subclass	Date	Examiner
156	276,307.7	10/25/2005	JLG
252	519.31	10/25/2005	JLG
252	519.33	10/25/2005	JLG
252	520.1	10/25/2005	JLG
Above	UPDATED	6/13/2006	JLG

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner